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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/670,877	09/27/2000	KAZUO ICHIKAWA	107469	7376
25944 · 7590 12/03/2004			EXAMINER	
OLIFF & BER	,		ZERVIGON, RUDY	
P.O. BOX 19928	5			
ALEXANDRIA,	, VA 22320		ART UNIT	PAPER NUMBER
			1763	

DATE MAILED: 12/03/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)	
	0.00	09/670,877	ICHIKAWA ET AL.	:
	Office Action Summary	Examiner	Art Unit	on
	· · · · · · · · · · · · · · · · · · ·	Rudy Zervigon	1763	<i>></i>
Period fo	The MAILING DATE of this communication ap or Reply	pears on the cover shee	t with the correspondence add	ress
THE - Exte after - If the - If NC - Failu Any	ORTENED STATUTORY PERIOD FOR REPL MAILING DATE OF THIS COMMUNICATION. Insions of time may be available under the provisions of 37 CFR 1. SIX (6) MONTHS from the mailing date of this communication. It is period for reply specified above is less than thirty (30) days, a reput of the provision of the period for reply is specified above, the maximum statutory period are to reply within the set or extended period for reply will, by statuting the provision of the provision of the period for reply will. The period for reply will be set or extended period for reply will, by statuting the provision of the period for reply will. Set the period for reply will be set or extended period for reply will be statuting the period for reply will be set or extended period for reply wi	136(a). In no event, however, ma ly within the statutory minimum of will apply and will expire SIX (6) No.	y a reply be timely filed thirty (30) days will be considered timely. ADANDONED (35 U.S.C. & 133)	nmunication.
Status			•	
1) 🛛	Responsive to communication(s) filed on 20 S	entember 2004		
		action is non-final.		
3)[Since this application is in condition for allowa		atters, prosecution as to the r	merits is
	closed in accordance with the practice under			1101113 13
Dispositi	ion of Claims		,	
	Claim(s) 1-6 is/are pending in the application.			
	4a) Of the above claim(s) <u>3 and 4</u> is/are withdr	awn from consideration		
	Claim(s) is/are allowed.	awn nom consideration		
	Claim(s) 1,2,5 and 6 is/are rejected.			
	Claim(s) is/are objected to.			
	Claim(s) are subject to restriction and/o	r election requirement		
		r cloculon requirement.		
	on Papers			
	The specification is objected to by the Examine			
	The drawing(s) filed on is/are: a)☐ acc			
	Applicant may not request that any objection to the	-	` ,	
	Replacement drawing sheet(s) including the correct			
11)[The oath or declaration is objected to by the Ex	aminer. Note the attach	ed Office Action or form PTO	-152.
Priority u	nder 35 U.S.C. § 119			
	Acknowledgment is made of a claim for foreign ☑ All b)☐ Some * c)☐ None of:	priority under 35 U.S.C	. § 119(a)-(d) or (f).	
	1. Certified copies of the priority documents	s have been received.		
	Certified copies of the priority documents	s have been received in	Application No	
	3. Copies of the certified copies of the prior			age
	application from the International Bureau			· ·
* S	ee the attached detailed Office action for a list	of the certified copies no	ot received.	
Attachment((s)			
_	of References Cited (PTO-892)		Summary (PTO-413)	
	of Draftsperson's Patent Drawing Review (PTO-948)	Paper No	o(s)/Mail Date	
intorm بن ا Paper	ation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) No(s)/Mail Date	5)	Informal Patent Application (PTO-15	o2)
S. Patent and Tra TOL-326 (Re		tion Summary	Part of Paper No./Mail Date	20041201

DETAILED ACTION

Election/Restrictions

1. This application contains claims 3 and 4 drawn to an invention nonelected with traverse on April 22, 2003. A complete reply to the final rejection must include cancellation of nonelected claims or other appropriate action (37 CFR 1.144) See MPEP § 821.01.

Claim Rejections - 35 USC § 103

- 2. The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.
- Claims 1, 2, 5, and 6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hara 3. et al (U. S. Pat. 5,648,276) in view of Babayan et al (US 2002/0129902 A1). Hara et al teaches a CVD system (C₁, C₂; Figure 2; column 7, lines 7-8) provided with a plasma generator (Fig.3, "UE", column 7, lines 15-20) having a plasma generation chamber (Fig. 3 containing "PL"; column 7, lines 15-20), including a circumferential wall (QW; Figure 3; column 7, lines 10-15) made of an insulator ("quartz"), the plasma generation chamber (Fig. 3 containing "PL"; column 7, lines 15-20) being separated from a film deposition chamber (Fig. 3 "QW" and "SW"; column 7, lines 10-15) in which a substrate (1) is arranged, and a film is deposited (column 7, lines 7-8) on the substrate within the same chamber (Fig. 3 "QW" and "SW"; column 7, lines 10-15) as the substrate is not moved (Fig.3). A material gas (Fig.3, "Gas (SiH₄, etc)") is directly supplied into the film deposition chamber, radicals in the plasma are introduced into the film deposition chamber from the plasma generator through introduction holes ("ME", mesh, Fig.3) of a lower plate (lower half of "ME"), and a thin film ("a-Si:H", column 7, lines 5-10) is deposited on the substrate. A gas feeder ("Gas (Ar, ...)"; Fig.3) is provided to the plasma generator.

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Hara et al further teaches a silicon-based film is deposited on a substrate ("a-Si:H", column 7, lines 5-10, lines 65-67), then converting the silicon-based film to a crystalline silicon-based film by laser annealing (column 8, lines 5-11), then depositing a gate insulating film ("SiO₂"; column 8, lines 20-25) on the crystalline film by a CVD system comprised of a separate film deposition chamber and plasma generation chamber as described above. Plasma "cleaning" is discussed as a step prior to forming the gate insulating film (column 13, lines 9-20). Also, see column 14, lines 10-25 and column 17, lines 1-10.

Hara does not teach that the lower plate (lower half of "ME") is connected to ground thereby allowing only radicals to pass. Further, Hara does not teach diameters of his introduction holes thereby allowing only radicals to pass.

Babayan teaches a capacitively coupled plasma apparatus (Figure 1). Specifically, Babayan teaches both electrically conductive upper (26, 28) and electrically conductive lower (22) electrodes as grounded ([0042]) thereby allowing only radicals to pass ([0039]).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to ground Hara's upper electrode (ME) as taught by Babayan, and to optimize the dimension of Hara's introduction hole diameters thereby allowing only radicals to pass.

Motivation for Hara to ground is upper electrode as taught by Babayan and for Hara to optimize the dimension of Hara's introduction hole diameters thereby allowing only radicals to pass is to avoid ion induced damage (last line, [0039]). Further, it is well established that changes in apparatus dimensions are within the level of ordinary skill in the art.(Gardner v. TEC Systems, Inc., 725 F.2d 1338, 220 USPQ 777 (Fed. Cir. 1984), cert. denied, 469 U.S. 830, 225 USPQ

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232 (1984); In re Rose, 220 F.2d 459, 105 USPQ 237 (CCPA 1955); In re Rinehart, 531 F.2d

1048, 189 USPO 143 (CCPA 1976); See MPEP 2144.04).

Response to Arguments

4. Applicant's arguments filed on September 20, 2004 have been fully considered but they are not persuasive.

5. Applicant states:

In particular, neither Hara nor Babayan discloses or suggests radicals in a plasma are introduced

into a film deposition chamber from the plasma generator through introduction holes of a lower

plate. . . the lower plate is connected to ground as recited in independent claims 1 and 5.

Moreover, neither Hara nor Babayan discloses or suggests each of the introduction holes is

designed to pass the radicals only to the film deposition chamber, as recited in claim 1, and a

diameter of each of the introduction holes is designed to pass the radicals only to the film

deposition chamber, as recited in claim 5.

6. In response, the Examiner agrees with Applicant to the extent that only "Hara does not

teach that his lower plate (lower half of "ME") is not connected to ground thereby allowing only

radicals to pass. Further, Hara does not teach diameters of his introduction holes thereby

allowing only radicals to pass." As stated in prior actions. However, the Examiner has cited

Babayan who teaches a capacitively coupled plasma apparatus (Figure 1). Specifically, Babayan

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teaches both electrically conductive upper (26, 28) and electrically conductive lower (22) electrodes as grounded ([0042]) thereby allowing only radicals to pass –

In one embodiment, the invention confines the plasma to the powered and grounded electrodes, so that, for the most part, <u>only neutral reactive species</u> contact the substrate or work piece, thus avoiding ion bombardment and any significant ion-induced damage of the substrate or work piece.

"[0039]

Thus, as demonstrated by Babayan, Babayan's apparatus provides teaching and stated motivation for Applicant's claimed invention. Further, when the structure recited in the reference is substantially identical to that of the claims, claimed properties or functions are presumed to be inherent (In re Best, 562 F.2d 1252, 1255, 195 USPQ 430, 433 (CCPA 1977); MPEP 2112.01). As is well known in the art, plasmas contain charged and uncharged, i.e. "neutral", gas species. Babayan's "neutral reactive species" must then also include Applicant's claimed "radicals".

7. Applicant states:

In paragraph (0042) of Babayan, members 26 and 28 are perforated sheets. Member 22 is a pedestal. These members 22, 26 and 28 are grounded, but are not expressed as "electrode". Rather, in Fig. 1 and at paragraph (0042), Babayan discloses that the conductive upper electrode is the member 16, and the conductive lower electrode is the member 14.

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8. In response, Applicant's argument that Babayan's members 26 and 28 are only

"perforated sheets" which are grounded, yet are not "electrodes" flys in the face of art-accepted

definitions:

Cathode¹: n 2 the electron-emitting electrode of an electron tube

The Examiner asserts that Babayan's members 26 and 28 are negative conductive sheets, and are

thus electrodes.

9. Applicant states, with regard to Babayan:

"

Therefore, the perforated sheets 26 and 28 plays no role in preventing passage of plasma, or the

passing of only the radicals. That is, the electrically conductive upper electrodes (26, 28) and the

electrically conductive lower electrode (22) as grounded perform different functions than that of

the claimed lower plate.

"However, the Examiner has already demonstrated above in paragraph 6 above ([0039]) that

Babayan's apparatus and teaching play central roles in preventing passage of plasma, and the

passing of only the radicals.

10. In response to applicant's arguments (second paragraph page 3) against the references

individually, one cannot show nonobviousness by attacking references individually where the

rejections are based on combinations of references. See In re Keller, 642 F.2d 413, 208

USPQ 871 (CCPA 1981); In re Merck & Co., 800 F.2d 1091, 231 USPQ 375 (Fed. Cir. 1986).

11. Applicant states:

"

¹ Merriam-Webster's Collegiate Dictionary, 10th Ed., pp.181.

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Furthermore, Hara does not disclose or suggest that a cleaning gas feeder that is provided to a

plasma generator. . .wherein a cleaning gas is introduced through the cleaning gas feeder to

produce plasma in the plasma generator and generate radicals, as recited in independent claim 1,

and similarly recited in independent claim 5....(page 3)

Moreover, claims 1 and 5 recite the radicals are introduced. . .to the film deposition chamber to

strike the substrate and thereby clean the substrate and further the film is deposited on the

substrate within the same chamber, as the substrate is not moved. Nowhere does Hara disclose or

suggest that the substrate is cleaned and a film is deposited on the substrate within the same

chamber. (page 4)

12. In response to applicant's arguments, a recitation of the intended use of the claimed

invention must result in a structural difference between the claimed invention and the prior art in

order to patentably distinguish the claimed invention from the prior art. If the prior art structure

is capable of performing the intended use, then it meets the claim. In a claim drawn to a process

of making, the intended use must result in a manipulative difference as compared to the prior art.

See In re Casey, 152 USPQ 235 (CCPA 1967) and In re Otto, 136 USPQ 458, 459 (CCPA

1963). In fact, it has been demonstrated that Hara teaches a gas feeder ("Gas (Ar, ...)"; Fig.3),

however, that the gas feed does not feed a "cleaning gas" is not a distinguishing structural claim

requirement in apparatus claims as pending.

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Conclusion

13. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

14. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Examiner Rudy Zervigon whose telephone number is (571) 272.1442. The examiner can normally be reached on a Monday through Thursday schedule from 8am through 7pm. The official after fax phone number for the 1763 art unit is (703) 872-9306. Any Inquiry of a general nature or relating to the status of this application or proceeding should be directed to the Chemical and Materials Engineering art unit receptionist at (571) 272-1700. If the examiner can not be reached please contact the examiner's supervisor, Gregory L. Mills, at (571) 272-1439.